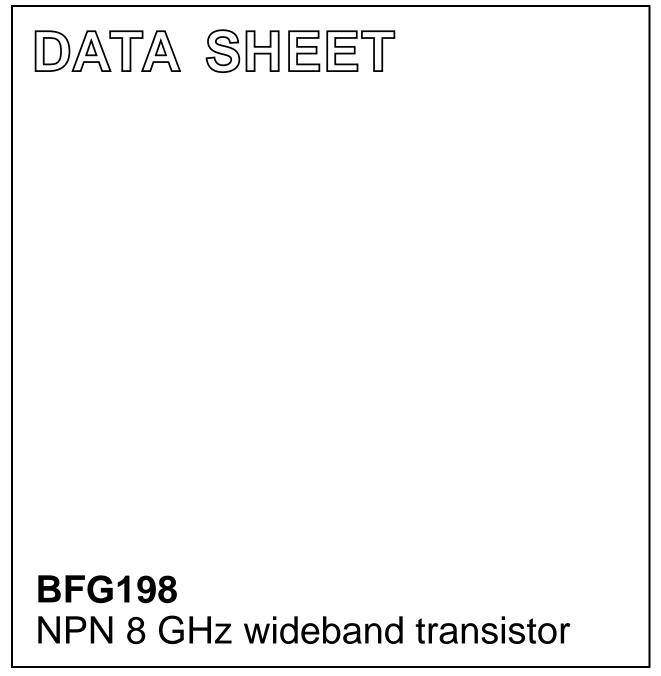
DISCRETE SEMICONDUCTORS



Product specification

1995 Sep 12

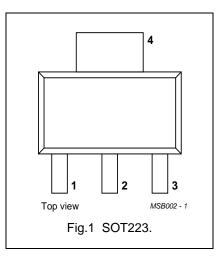


## DESCRIPTION

NPN planar epitaxial transistor in a plastic SOT223 envelope, intended for wideband amplifier applications. The device features a high gain and excellent output voltage capabilities.

### PINNING

PIN	DESCRIPTION	
1	emitter	
2	base	
3	emitter	
4	collector	



## QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	_	20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	-	10	V
I <sub>C</sub>	DC collector current		-	-	100	mA
P <sub>tot</sub>	total power dissipation	up to $T_s = 135 \ ^{\circ}C$ (note 1)	_	_	1	W
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 50 mA; V <sub>CE</sub> = 5 V; T <sub>j</sub> = 25 °C	40	90	-	
f <sub>T</sub>	transition frequency	$I_C = 50 \text{ mA}; V_{CE} = 8 \text{ V}; \text{ f} = 1 \text{ GHz};$ $T_{amb} = 25 \text{ °C}$	-	8	-	GHz
G <sub>UM</sub>	maximum unilateral power gain	$I_C = 50 \text{ mA}; V_{CE} = 8 \text{ V}; \text{ f} = 500 \text{ MHz};$ $T_{amb} = 25 \text{ °C}$	-	18	_	dB
		$I_C = 50 \text{ mA}; V_{CE} = 8 \text{ V}; \text{ f} = 800 \text{ MHz};$ $T_{amb} = 25 \text{ °C}$	-	15	-	dB
Vo	output voltage		_	700	_	mV

### LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	-	20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	-	10	V
V <sub>EBO</sub>	emitter-base voltage	open collector	-	2.5	V
I <sub>C</sub>	DC collector current		-	100	mA
P <sub>tot</sub>	total power dissipation	up to $T_s = 135 \text{ °C}$ (note 1)	-	1	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		-	175	°C

## Note

1.  $T_s$  is the temperature at the soldering point of the collector tab.

# **BFG198**

## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALU E	UNIT
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	up to $T_s = 135 \ ^{\circ}C$ (note 1)	40	K/W
Noto				

Note

1.  $T_s$  is the temperature at the soldering point of the collector tab.

## CHARACTERISTICS

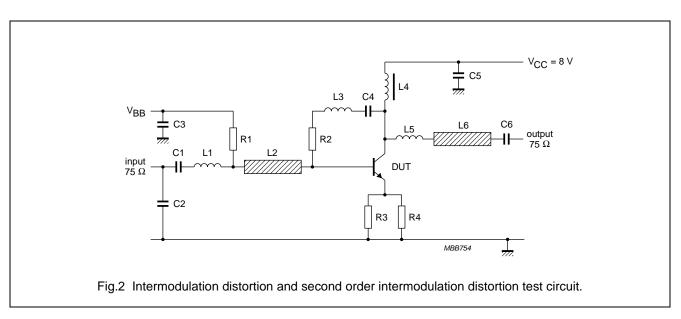
 $T_j = 25 \ ^{\circ}C$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector cut-off current	I <sub>E</sub> = 0; V <sub>CB</sub> = 5 V	-	-	100	nA
h <sub>FE</sub>	DC current gain	$I_{C} = 50 \text{ mA}; V_{CE} = 5 \text{ V}$	40	90	-	
C <sub>c</sub>	collector capacitance	I <sub>E</sub> = i <sub>e</sub> = 0; V <sub>CB</sub> = 8 V; f = 1 MHz	-	1.5	-	pF
C <sub>e</sub>	emitter capacitance	$I_{C} = i_{c} = 0; V_{EB} = 0.5 V; f = 1 MHz$	-	4	-	pF
C <sub>re</sub>	feedback capacitance	I <sub>C</sub> = 0; V <sub>CE</sub> = 8 V; f = 1 MHz	-	0.8	-	pF
f <sub>T</sub>	transition frequency	$I_{C}$ = 50 mA; $V_{CE}$ = 8 V; f = 1 GHz; $T_{amb}$ = 25 °C	-	8	-	GHz
G <sub>UM</sub>	maximum unilateral power gain; note 1	$I_{C} = 50 \text{ mA}; V_{CE} = 8 \text{ V}; f = 500 \text{ MHz};$ $T_{amb} = 25 \text{ °C}$	-	18	-	dB
		$I_{C}$ = 50 mA; V <sub>CE</sub> = 8 V; f = 800 MHz; T <sub>amb</sub> = 25 °C	-	15	-	dB
Vo	output voltage	note 2	_	750	_	mV
		note 3	-	700	_	mV
d <sub>2</sub>	second order intermodulation distortion	note 4	-	-55	-	dB

### Notes

- 1.  $G_{UM}$  is the maximum unilateral power gain, assuming  $S_{12}$  is zero and  $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1-|s_{11}|^2)(1-|s_{22}|^2)} dB$ .
- 2.  $d_{im} = -60 \text{ dB} \text{ (DIN 45004B)}; I_C = 70 \text{ mA}; V_{CE} = 8 \text{ V}; R_L = 75 \Omega; T_{amb} = 25 \text{ °C};$   $V_p = V_o \text{ at } d_{im} = -60 \text{ dB};$   $V_q = V_o -6 \text{ dB}; f_p = 445.25 \text{ MHz};$   $V_r = V_o -6 \text{ dB}; f_q = 453.25 \text{ MHz}; f_r = 455.25 \text{ MHz}$ measured at  $f_{(p+q-r)} = 443.25 \text{ MHz}.$
- 3.  $d_{im} = -60 \text{ dB} \text{ (DIN 45004B)}; I_C = 70 \text{ mA}; V_{CE} = 8 \text{ V}; R_L = 75 \Omega; T_{amb} = 25 \text{ °C};$   $V_p = V_o \text{ at } d_{im} = -60 \text{ dB}; f_p = 795.25 \text{ MHz};$   $V_q = V_o - 6 \text{ dB}; f_q = 803.25 \text{ MHz};$   $V_r = V_o - 6 \text{ dB}; f_r = 805.25 \text{ MHz};$ measured at  $f_{(p+q-r)} = 793.25 \text{ MHz}.$
- $\begin{array}{ll} \text{4.} & I_C = 50 \text{ mA}; \text{ } \text{V}_{\text{CE}} = 8 \text{ } \text{V}; \text{ } \text{V}_{\text{o}} = 50 \text{ } \text{dBmV}; \\ & f_{(\text{p}+\text{q})} = 810 \text{ } \text{MHz}; \text{ } f_{\text{p}} = 250 \text{ } \text{MHz}; \text{ } f_{\text{q}} = 560 \text{ } \text{MHz}. \end{array}$

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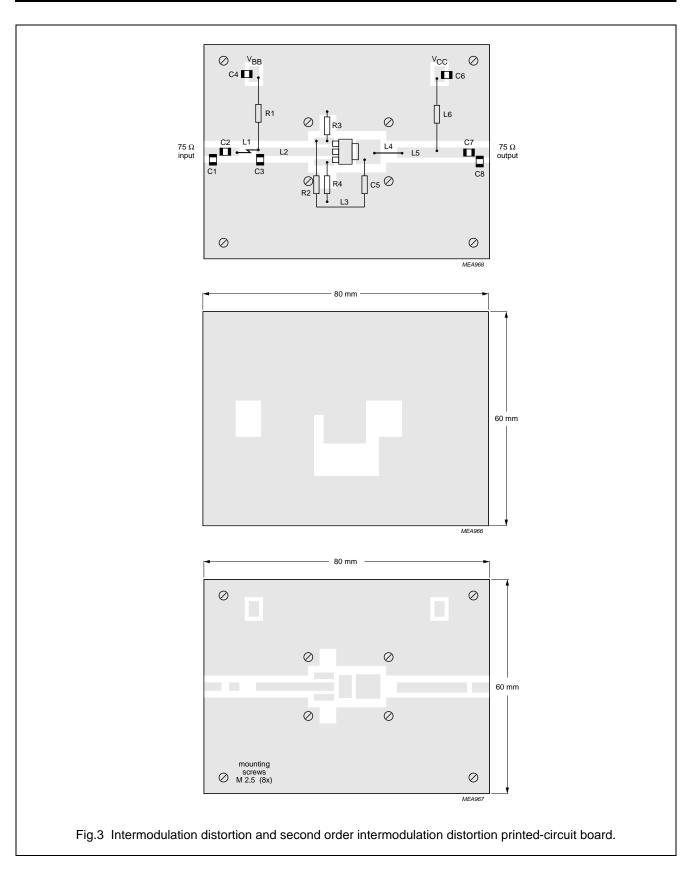


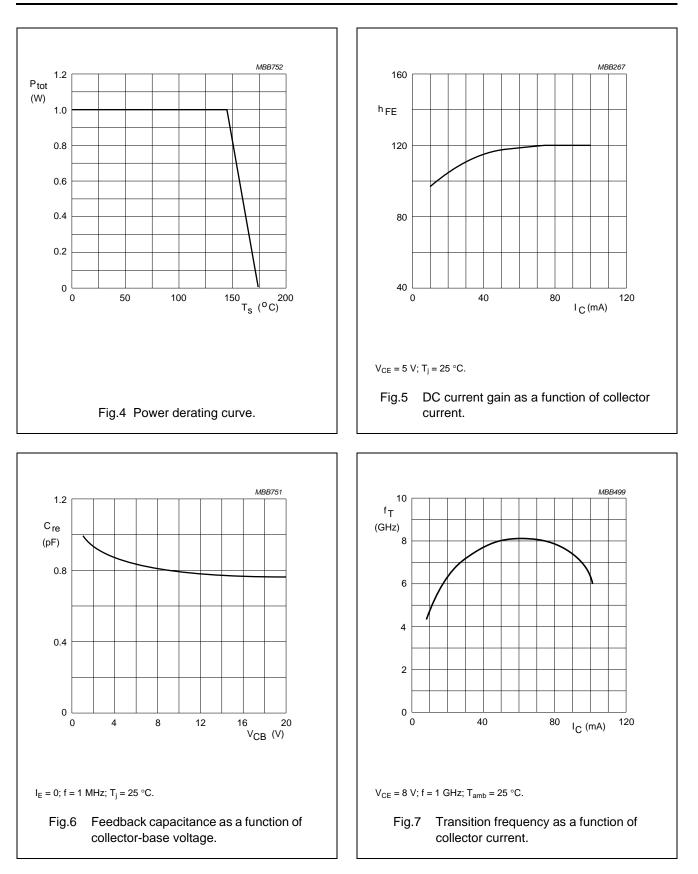
DESIGNATION	DESCRIPTION	VALUE	UNIT	DIMENSIONS	CATALOGUE NO.
C2	multilayer ceramic capacitor	1.2	pF		2222 851 12128
C1, C4, C6, C7	multilayer ceramic capacitor	10	nF		2222 590 08627
C3	multilayer ceramic capacitor	10	nF		2222 851 12128
C5 (note 1)	multilayer ceramic capacitor	10	nF		2222 629 08103
C8	multilayer ceramic capacitor	1.5	pF		2222 851 12158
L1 (note 1)	1.5 turns 0.4 mm copper wire			int. dia. 3 mm; winding pitch 1 mm	
L2	microstripline	75	Ω	length 22 mm; width 2.5 mm	
L3 (note 1)	0.4 mm copper wire	≈24	nH	length 30 mm	
L4 (note 1)	0.4 mm copper wire	≈3.6	nH	length 4 mm	
L5	microstripline	75	Ω	length 19 mm; width 2.5 mm	
L6	Ferroxcube choke	5	μH		3122 108 20153
R1	metal film resistor	10	Ω		2322 180 73103
R2 (note 1)	metal film resistor	220	Ω		2322 180 73221
R3, R4	metal film resistor	30	Ω		2322 180 73309

## List of components (see test circuit)

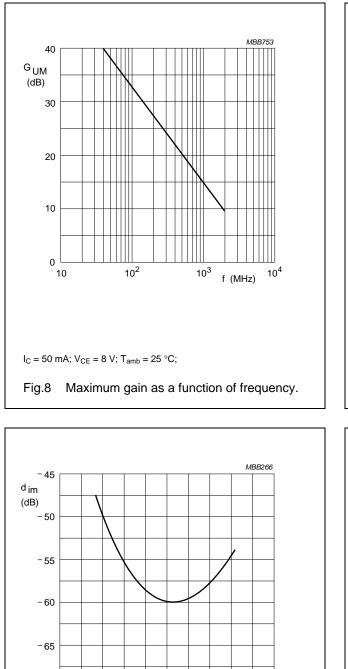
#### Note

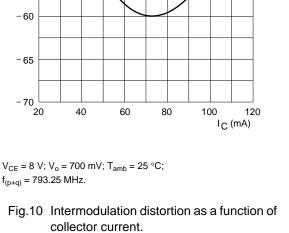
1. Components C5, L1, L3, L4, and R2 are mounted on the underside of the PCB. The circuit is constructed on a double copper-clad printed circuit board with PTFE dielectric ( $\epsilon_r = 2.2$ ); thickness  $\frac{1}{16}$  inch; thickness of copper sheet 2 x 35  $\mu$ m; see Fig.2.

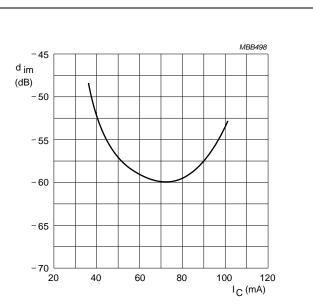




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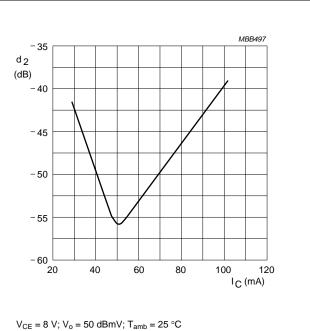






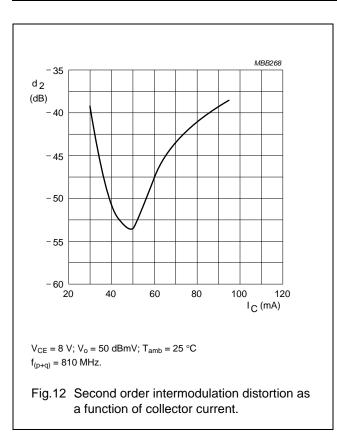
 $\label{eq:VCE} \begin{array}{l} V_{CE} = 8 \ V; \ V_{o} = 750 \ mV; \ T_{amb} = 25 \ ^{\circ}C; \\ f_{(p+q-r)} = 443.25 \ MHz. \end{array}$ 

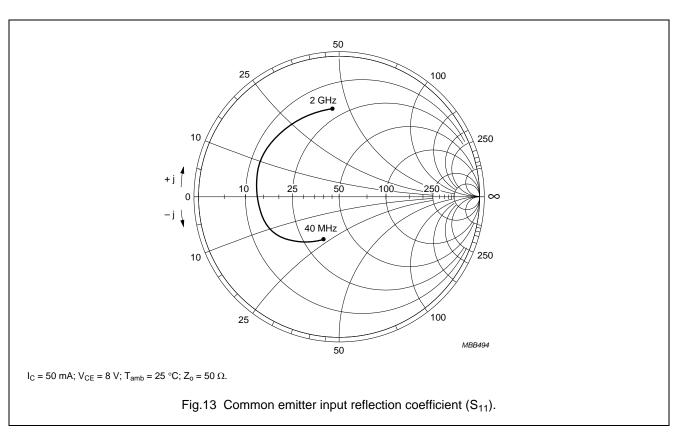
Fig.9 Intermodulation distortion as a function of collector current.

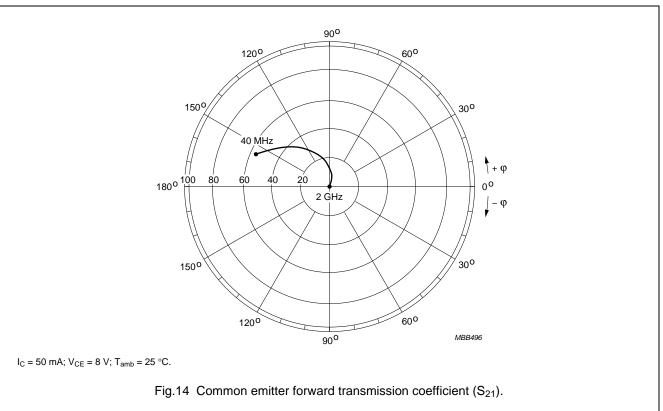


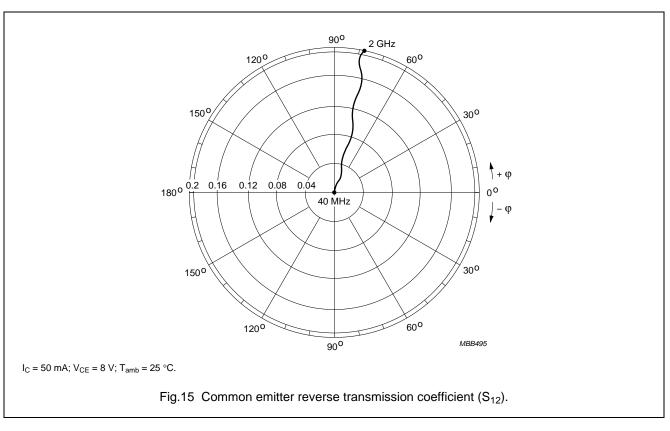
 $f_{(p+q)} = 450 \text{ MHz}.$ 

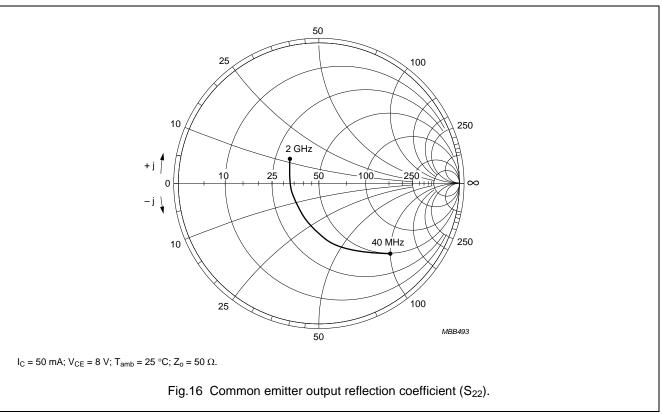
Fig.11 Second order intermodulation distortion as a function of collector current.



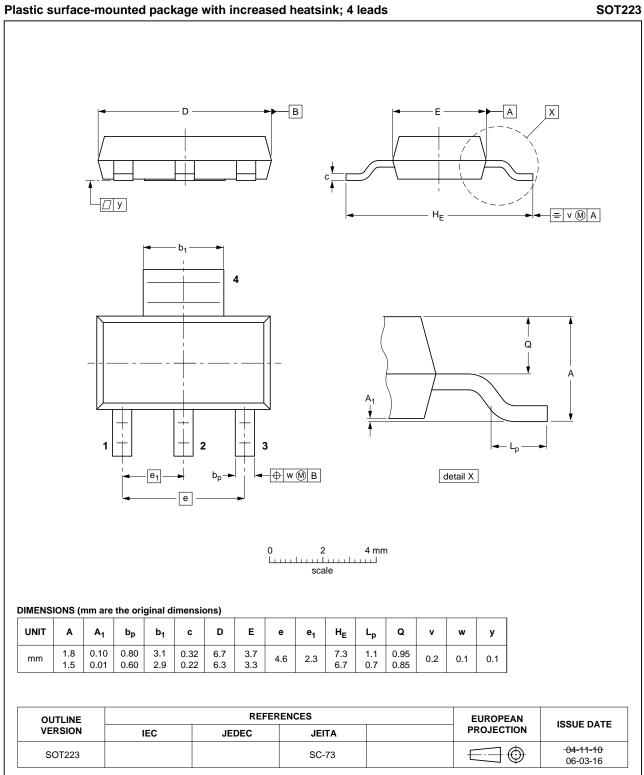








## **PACKAGE OUTLINE**



**BFG198** 

## DATA SHEET STATUS

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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